CTH1804PS-T52

P-Channel Enhancement MOSFET

Features

- Drain-Source Breakdown Voltage V_{DSS} -40V
- Drain-Source On-Resistance
  $R_{DS(ON)}$ 35mΩ, *at* V_{GS}= *-10V,* I_D= *-12A*
  $R_{DS(ON)}$ 57mΩ, *at* V_{GS}= *-4.5V,* I_D= *-6A*
- *Continuous D*rain Current at T_C=25°C I_D =-18.6A
- Advanced high cell density Trench Technology
- RoHS Compliance & Halogen Free

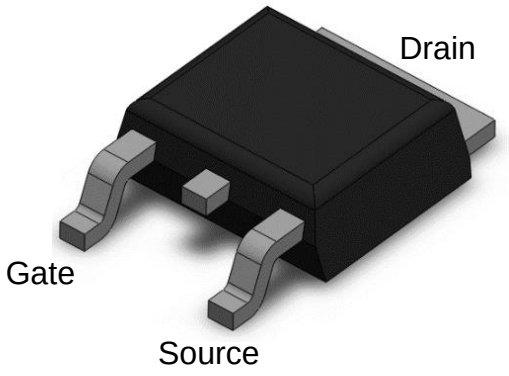
Description

The CTH1804PS-T52 is the P-Channel logic enhancement mode power field effect transistors are produced using high cell density, DMOS trench technology. This high density process is especially tailored to minimize on-state resistance.

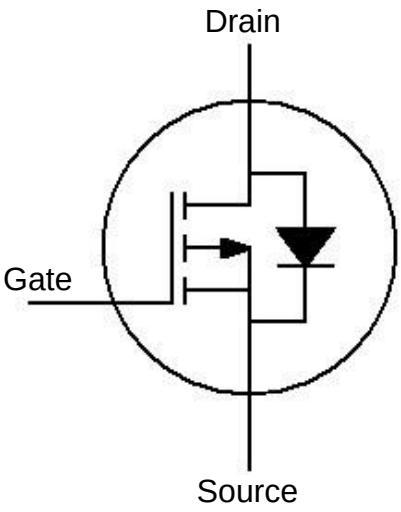
Applications

- Load Switch
- DC/DC Converter
- LCD Display inverter

Package Outline



Schematic



Absolute Maximum Rating at 25ºC

Symbol	Parameters	Test Conditions	Min	Note
V_{DS}	Drain-Source Voltage	-40	V	
V_{GS}	Gate-Source Voltage	±25	V	
I_D	Continuous Drain Current @T_C=25˚C	-18.6	A	1
I_{DM}	Pulsed Drain Current	-75	A	1
P_D	Total Power Dissipation @T_C=25˚C	25	W	2
T_{STG}	Storage Temperature Range	-55 to 150	°C	
T_J	Operating Junction Temperature Range	-55 to 150	°C	

Thermal Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
$R_{\theta JC}$	Thermal Resistance Junction-Case		--	--	5	ºC /W	1,4

Electrical Characteristics T_C = 25°C (unless otherwise specified)

Static Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
B_{VDSS}	Drain-Source Breakdown Voltage	V_{GS}= 0V, I_D= -250μA	-40	-	-	V	
I_{DSS}	Drain-Source Leakage Current	V_{DS} = -40V, V_{GS} = 0V	-	-	-1	μA	
I_{GSS}	Gate-Source Leakage Current	V_{GS} = ±25V, V_{DS} = 0V	-	-	±100	nA	

On Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
$R_{DS(ON)}$	Drain-Source On-Resistance	V_{GS} = -10V, I_D = -12A	-	35	45	mΩ	3
		V_{GS} = -4.5V, I_D = -6A	-	57	80	mΩ	3
$V_{GS(th)}$	Gate-Source Threshold Voltage	V_{GS} = V_{DS}, I_D =-250μA	-1.0	-1.9	-3.0	V	3

Dynamic Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
C_{ISS}	Input Capacitance	V_{GS} =0V,	-	860	-	pF	
C_{OSS}	Output Capacitance	V_{DS} =-20V	-	120	-		
C_{RSS}	Reverse Transfer Capacitance	f=1MHz	-	35	-		

Switching Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
$T_{D(ON)}$	Turn-On Delay Time	V_{DS} = -15V,	-	30	-	ns	
T_R	Rise Time	R_L = 15Ω,	-	8.5	-		
$T_{D(OFF)}$	Turn-Off Delay Time	V_{GS} = -10V,	-	70	-		
T_F	Fall Time	R_G = 6Ω,	-	7	-		
Q_G	Total Gate Charge	V_{DS} = -20V ,	-	10	-	nC	
Q_{GS}	Gate-Source Charge	V_{GS} = -4.5V,	-	4.3	-		
Q_{GD}	Gate-Drain (Miller) Charge	I_D =-12A	-	4.5	-		

Drain-Source Diode Characteristics

Symbol	Parameters	Test Conditions	Min	Typ	Max	Units	Notes
V_{SD}	Body Diode Forward Voltage	V_{GS} = 0V, I_{SD} = -1.7A	-	-0.78	-1.2	V	1
I_{SD}	Body Diode Continuous Current		-	-	-1.7	A	1

Note:

1. The power dissipation is limited by 150°C junction temperature.
2. The data tested by pulsed , pulse width ≤ 300μs , duty cycle ≤ 2%
3. Thermal Resistance follow JESD51-3.

Typical Characteristic Curves

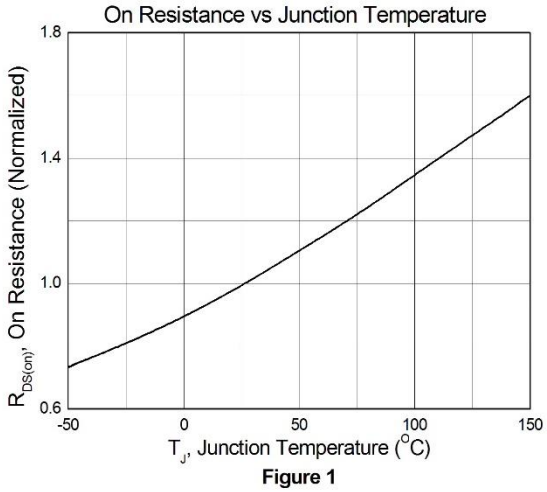


Figure 1

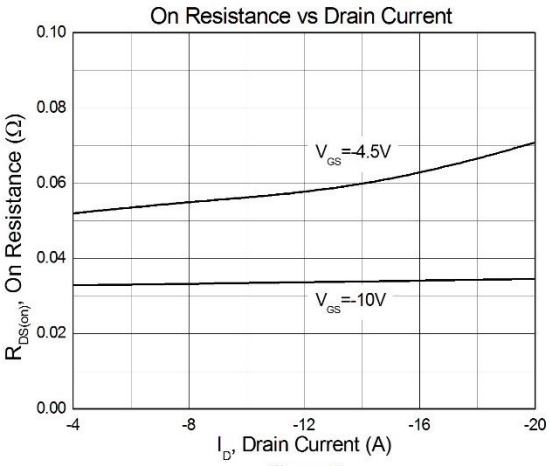


Figure 2

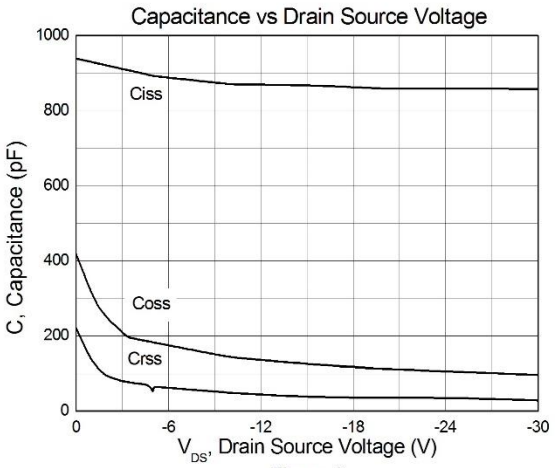


Figure 3

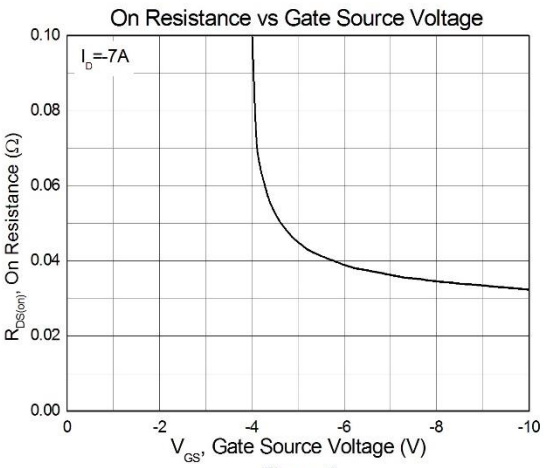


Figure 4

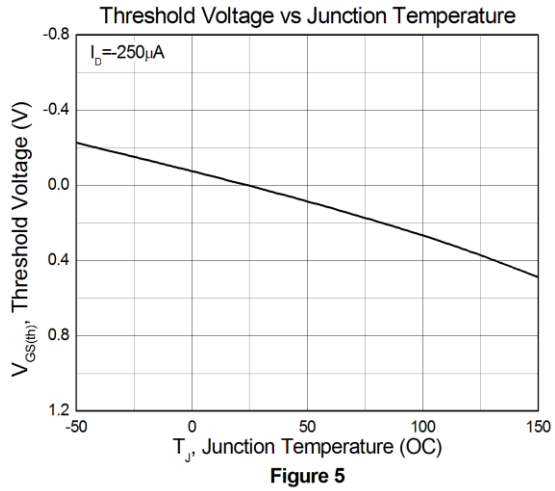


Figure 5

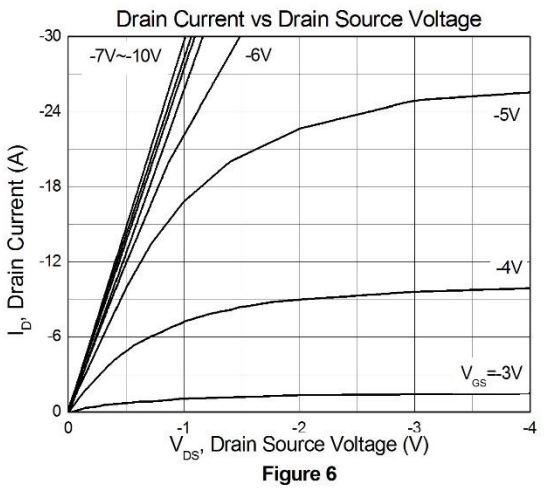


Figure 6

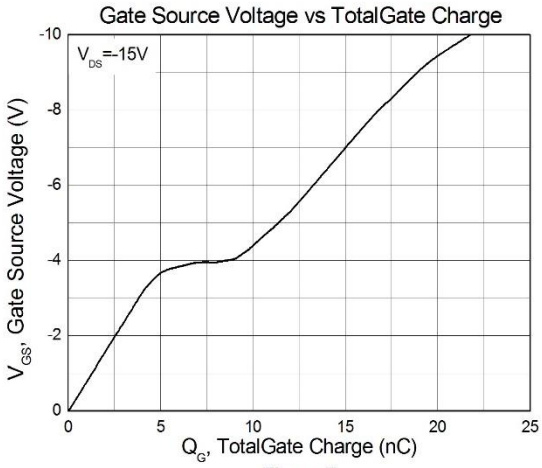


Figure 7

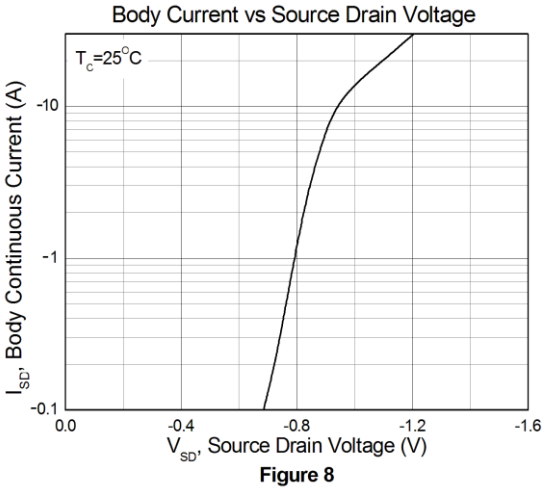


Figure 8

Test Circuits & Waveforms

Figure 9: Gate Charge Test Circuit

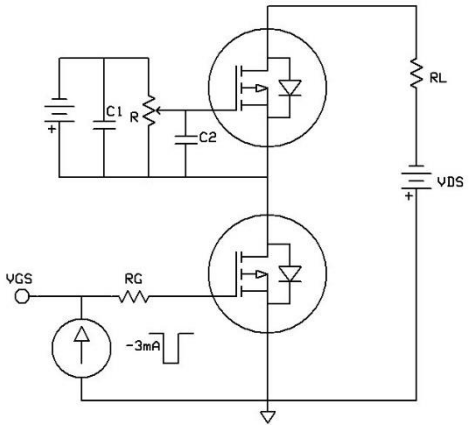


Figure 10: Gate Charge Waveform

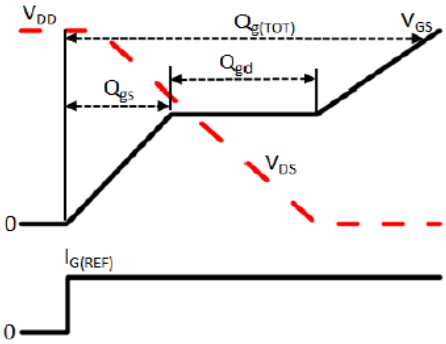


Figure 11: Switching Time Test Circuit

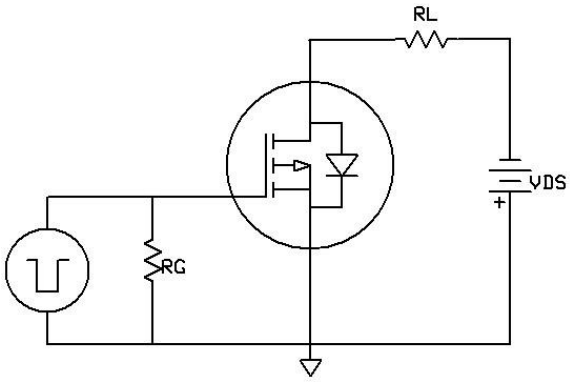
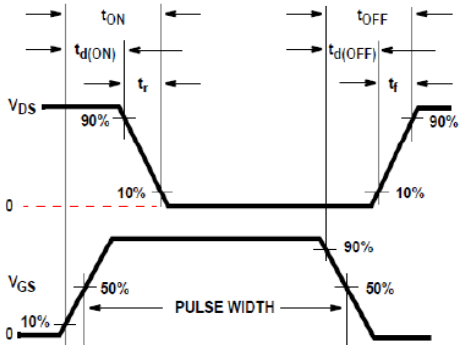
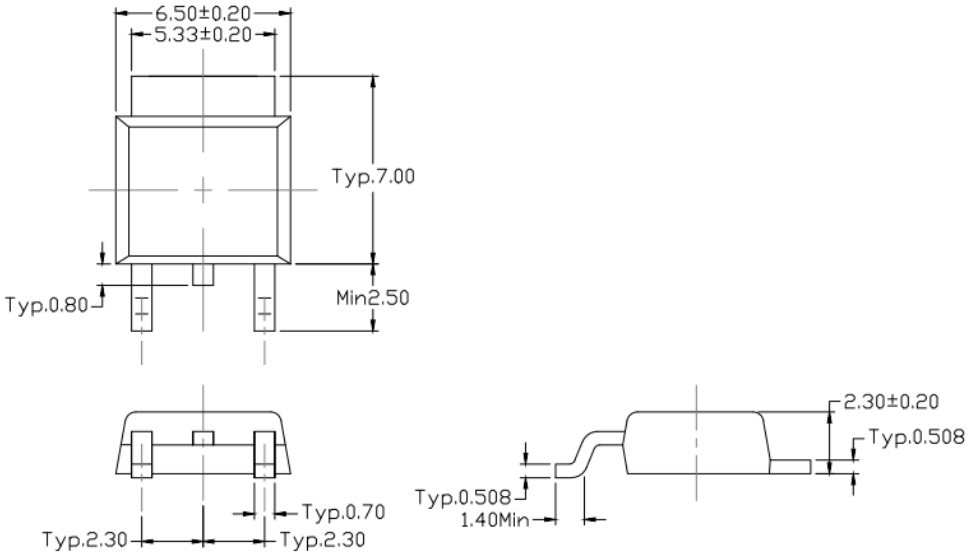


Figure 12: Switching Time Waveform

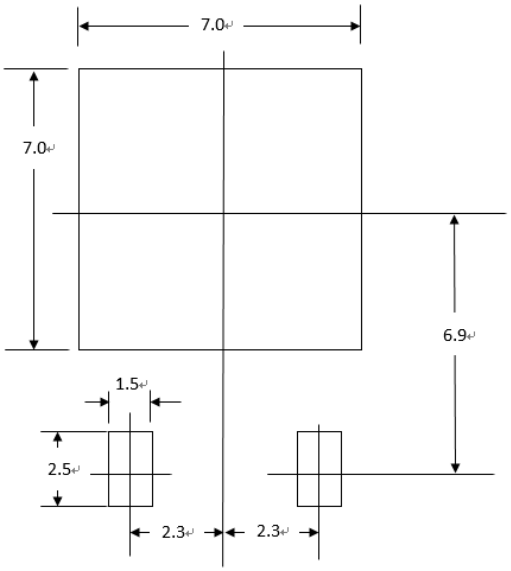


Package Dimension (TO-252)



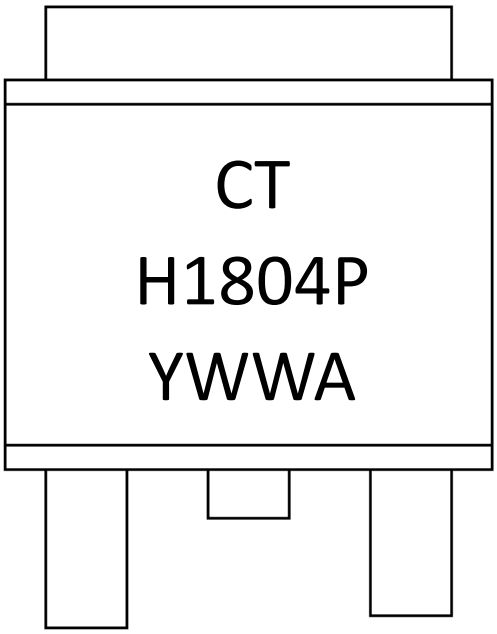
Dimensions in mm unless otherwise stated

Recommended pad layout for surface mount leadform



Dimensions in mm unless otherwise stated

Marking Information

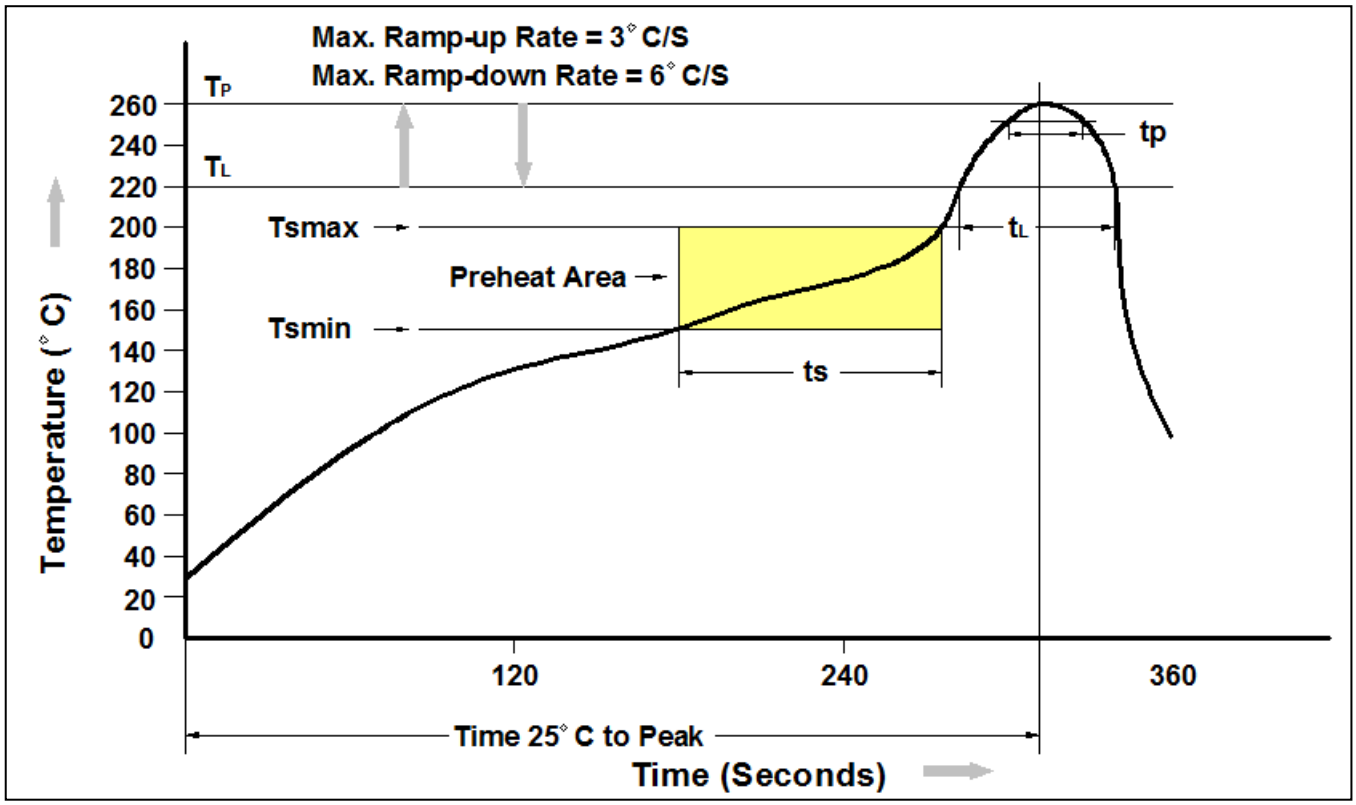


CT ：Denotes “ CT Micro”
H1804P ：Device Number
Y ：Fiscal Year
WW ：Work Week
A ：Production Code

Ordering Information

Part Number	*Description*	*Quantity*
CTH1804PS-T52	TO-252 Reel	2500 pcs

Reflow Profile



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmin to Tsmax)	60-120 seconds
Ramp-up Rate (t_L to t_P)	3°C/second max.
Liquidous Temperature (T_L)	217°C
Time (t_L) Maintained Above (T_L)	60 – 150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (t_P) within 5°C of 260°C	30 seconds
Ramp-down Rate (T_P to T_L)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.

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